TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type (U-MOS III)

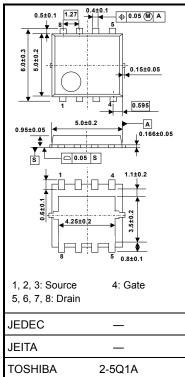
TPCA8104

High-Side Switching Applications Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON-resistance: R_{DS} (ON) = 11 m Ω (typ.)
- High forward transfer admittance: $|\,Y_{\rm fs}\,|$ = 50 S (typ.)
- Low leakage current: $I_{\rm DSS}$ = -10 $\mu A \, (V_{\rm DS}$ = -60 V)
- Enhancement mode: V_{th} = -0.8 to -2.0 V (V_{DS} = -10 V, I_D = -1 mA)

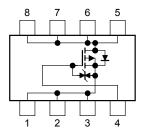
			•			
Characteristic			Symbol	Rating	Unit	
Drain-source voltage			V _{DSS}	-60	V	
Drain-gate vol	tage (R _{GS} =	20 kΩ)	V _{DGR}	-60	V	
Gate-source v	oltage		V _{GSS}	±20	V	
Drain ourrant	DC	(Note 1)	ID	-40	Α	
Drain current	rain current $Pulse$ $(Note 1)$ I_{DP} -120 Pulse $(Note 1)$ I_{DP} -120 rain power dissipation (Tc = 25°C) P_D 45rain power dissipation (t = 10 s) (Note 2a) P_D 2.8	-120	A			
Drain power d	issipation (T	c = 25°C)	PD	45		
Drain power dissipation (t = 10 s) (Note 2a)			PD	2.8	w	
Drain power dissipation (t = 10 s) (Note 2b)			PD	1.6		
Single-pulse avalanche energy (Note 3)			E _{AS}	116	mJ	
Avalanche cur	valanche current I _{AR} -40				A	
Repetitive avalanche energy (Tc = 25°C) (Note 4)			E _{AR}	4.5	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature range			T _{stg}	-55~150	°C	

Absolute Maximum Ratings (Ta = 25°C)



Weight: 0.080 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, see the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

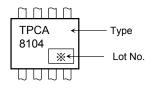
This transistor is an electrostatic-sensitive device. Handle with care.

Unit: mm

Thermal Characteristics

Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to case (Tc = 25°C)	R _{th (ch-c)}	2.78	°C/W	
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a)	R _{th (ch-a)}	44.6	°C/W	
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2b)	R _{th (ch-b)}	78.1	0/10	

Marking (Note 5)



Note 1: The channel temperature should not exceed 150 $^{\circ}\mathrm{C}$ during use.

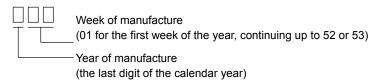
Note 2: (a) Device mounted on a glass-epoxy board (a)



(b) Device mounted on a glass-epoxy board (b)

Note 3: $V_{DD} = -24 \text{ V}$, $T_{Ch} = 25^{\circ}\text{C}$ (initial), L = 0.1 mH, $R_G = 25 \Omega$, $I_{AR} = -40 \text{ A}$ Note 4: Repetitive rating: pulse width limited by maximum channel temperature.

Note 5: * Weekly code (three digits):



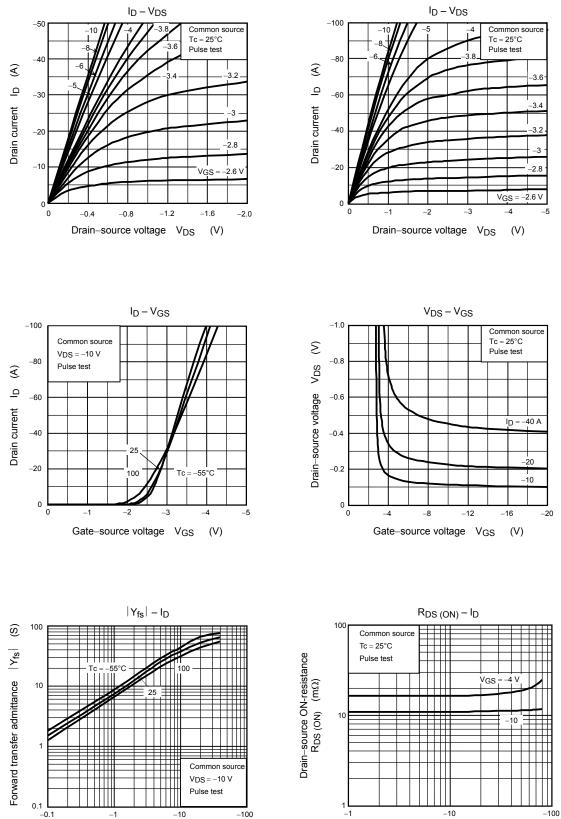
Electrical Characteristics (Ta = 25°C)

Cha	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	V_{GS} = ±16 V, V_{DS} = 0 V	_		±10	μA
Drain cutoff current		I _{DSS}	V_{DS} = -60 V, V_{GS} = 0 V	_		-10	μA
Drain-source breakdown voltage		V (BR) DSS	I_D = -10 mA, V_{GS} = 0 V	-60	_	_	v
		V (BR) DSX	$I_{\rm D}$ = -10 mA, $V_{\rm GS}$ = 20 V	-35	_	_	
Gate threshold voltage		V _{th}	V_{DS} = -10 V, I _D = -1 mA	-0.8		-2.0	V
Desire and ON		_	V_{GS} = -4 V, I _D = -20 A		17	24	
Drain-source ON-resistance		R _{DS} (ON)	V _{GS} = -10 V, I _D = -20 A		11	16	mΩ
Forward transfer admittance		Y _{fs}	V _{DS} = -10 V, I _D = -20 A	25	50		S
Input capacitance		C _{iss}		_	4300		pF
Reverse transfer capacitance		C _{rss}	V _{DS} = –10 V, V _{GS} = 0 V, f = 1 MHz		450		
Output capacitance		C _{oss}			600		
Switching time	Rise time	t _r	$V_{GS} = -20A$ $V_{GS} = -10 V$ $V_{DD} = -20A$ $V_{DD} = -20A$ $V_{D} = -20A$	_	10		- ns
	Turn-on time	t _{on}		_	20	_	
	Fall time	t _f		_	60	_	
	Turn-off time	t _{off}			200	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈48 V, V _{GS} =10 V		90		nC
Gate-source charge 1		Q _{gs1}	I _D = -40 A	_	16	_	
Gate-drain ("Miller") charge		Q _{gd}		_	28	—	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	_	_	-120	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = -40 A, V _{GS} = 0 V	_		1.2	V

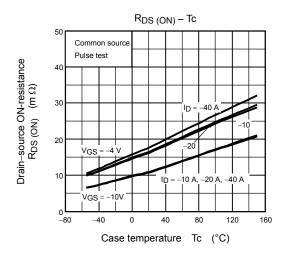
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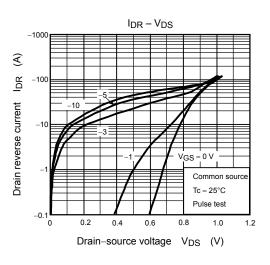


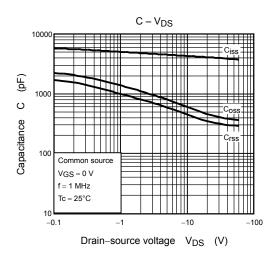
Drain currrent I_D (A)

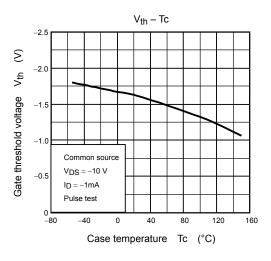
Drain current ID (A)

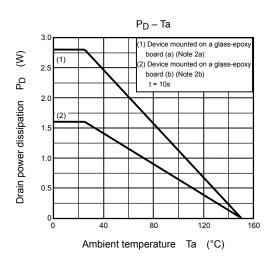
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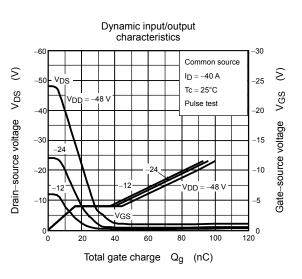


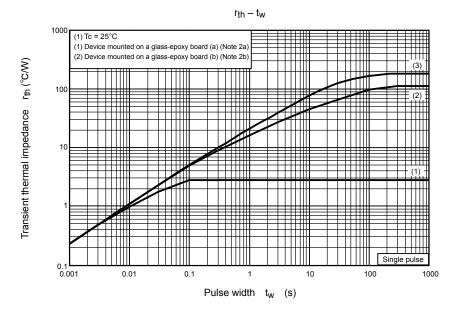


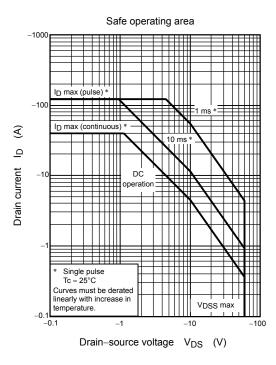


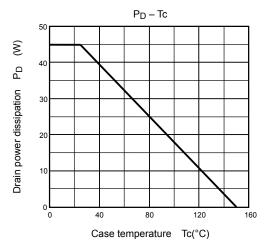












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